

Notice of References Cited

Application/Control No.

10/525,204

Applicant(s)/Patent Under
Reexamination
TAKEYAMA ET AL.

Examiner

ALTREV C. SYKES

Art Unit

4145

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0022575 A1	01-2003	Yoneda et al.	442/104
*	B	US-4,206,257	06-1980	Fukushima et al.	428/91
	C	US-			
	D	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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